Applicant(s)/Patent Under Application/Control No. Reexamination 10/645,815 **BOUTAGHOU ET AL.** Notice of References Cited Art Unit Examiner Page 1 of 1 2627 Tianjie Chen **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2001/0030836 10-2001 Katsumata, Makoto 360/244.1 Α US-В US-C US-D Ε US-F US-US-G USн US-1 US-J US-Κ US-М US-**FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Х